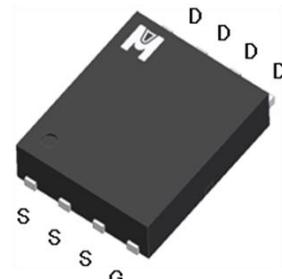
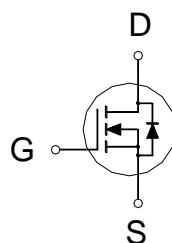


N-Channel Logic Level Enhancement Mode Field Effect Transistor

Product Summary:

| | |
|---------------------|----------------------|
| BV_{DSS} | 100V |
| $R_{DS(on)}$ (MAX.) | $16.5\text{m}\Omega$ |
| I_D | 44A |



UIS, Rg 100% Tested

RoHS & Halogen Free & TSCA Compliant



ABSOLUTE MAXIMUM RATINGS ($T_c = 25^\circ\text{C}$ Unless Otherwise Noted)

| PARAMETERS/TEST CONDITIONS | | SYMBOL | LIMITS | UNIT |
|--|--|----------------|------------|------|
| Gate-Source Voltage | | V_{GS} | ± 20 | V |
| Continuous Drain Current | $T_c = 25^\circ\text{C}$ | I_D | 44 | A |
| | $T_c = 100^\circ\text{C}$ | | 28 | |
| Pulsed Drain Current ¹ | | I_{DM} | 100 | |
| Avalanche Current | | I_{AS} | 20 | |
| Avalanche Energy | $L = 0.1\text{mH}, I_D=20\text{A}, R_G=25\Omega$ | E_{AS} | 20 | mJ |
| Repetitive Avalanche Energy ² | $L = 0.05\text{mH}$ | E_{AR} | 10 | |
| Power Dissipation | $T_c = 25^\circ\text{C}$ | P_D | 50 | W |
| | $T_c = 100^\circ\text{C}$ | | 20 | |
| Operating Junction & Storage Temperature Range | | T_j, T_{stg} | -55 to 150 | °C |

100% UIS testing in condition of $VD=50\text{V}$, $L=0.1\text{mH}$, $VG=10\text{V}$, $IL=12\text{A}$, Rated $VDS=100\text{V}$ N-CH

THERMAL RESISTANCE RATINGS

| THERMAL RESISTANCE | SYMBOL | TYPICAL | MAXIMUM | UNIT |
|---------------------|-----------------|---------|---------|--------|
| Junction-to-Case | $R_{\theta JC}$ | 2.5 | 62 | °C / W |
| Junction-to-Ambient | $R_{\theta JA}$ | | | |

¹Pulse width limited by maximum junction temperature.

²Duty cycle < 1%

³The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz.

Copper, in a still air environment with $T_A = 25^\circ\text{C}$.

⁴Guarantee by Engineering test

ELECTRICAL CHARACTERISTICS ($T_c = 25^\circ\text{C}$, Unless Otherwise Noted)

| PARAMETER | SYMBOL | TEST CONDITIONS | LIMITS | | | UNIT |
|---|-----------------------------|--|--------|------|-----------|------------------|
| | | | MIN | TYP | MAX | |
| STATIC | | | | | | |
| Drain-Source Breakdown Voltage | $V_{(\text{BR})\text{DSS}}$ | $V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$ | 100 | | | V |
| Gate Threshold Voltage | $V_{\text{GS}(\text{th})}$ | $V_{\text{DS}} = V_{\text{GS}}, I_D = 250\mu\text{A}$ | 1.0 | 2.0 | 3.0 | |
| Gate-Body Leakage | I_{GSS} | $V_{\text{DS}} = 0\text{V}, V_{\text{GS}} = \pm 20\text{V}$ | | | ± 100 | nA |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{\text{DS}} = 80\text{V}, V_{\text{GS}} = 0\text{V}$ | | | 1 | μA |
| | | $V_{\text{DS}} = 70\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 125^\circ\text{C}$ | | | 25 | |
| On-State Drain Current ¹ | $I_{\text{D}(\text{ON})}$ | $V_{\text{DS}} = 5\text{V}, V_{\text{GS}} = 10\text{V}$ | 44 | | | A |
| Drain-Source On-State Resistance ¹ | $R_{\text{DS}(\text{ON})}$ | $V_{\text{GS}} = 10\text{V}, I_D = 20\text{A}$ | | 14 | 16.5 | $\text{m}\Omega$ |
| | | $V_{\text{GS}} = 4.5\text{V}, I_D = 10\text{A}$ | | 16.5 | 21 | |
| Forward Transconductance ¹ | g_{fs} | $V_{\text{DS}} = 5\text{V}, I_D = 20\text{A}$ | | 42 | | S |
| DYNAMIC | | | | | | |
| Input Capacitance | C_{iss} | $V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 50\text{V}, f = 1\text{MHz}$ | | 4505 | | pF |
| Output Capacitance | C_{oss} | | | 195 | | |
| Reverse Transfer Capacitance | C_{rss} | | | 44 | | |
| Gate Resistance | R_g | $V_{\text{GS}} = 15\text{mV}, V_{\text{DS}} = 0\text{V}, f = 1\text{MHz}$ | | 1.6 | | Ω |
| Total Gate Charge ^{1,2} | Q_g | $V_{\text{DS}} = 50\text{V}, V_{\text{GS}} = 10\text{V}, I_D = 20\text{A}$ | | 64 | | nC |
| Gate-Source Charge ^{1,2} | Q_{gs} | | | 15 | | |
| Gate-Drain Charge ^{1,2} | Q_{gd} | | | 11 | | |
| Turn-On Delay Time ^{1,2} | $t_{\text{d}(\text{on})}$ | $V_{\text{DS}} = 50\text{V}, I_D = 5\text{A}, V_{\text{GS}} = 10\text{V}, R_G = 6\Omega$ | | 20 | | nS |
| Rise Time ^{1,2} | t_r | | | 20 | | |
| Turn-Off Delay Time ^{1,2} | $t_{\text{d}(\text{off})}$ | | | 50 | | |
| Fall Time ^{1,2} | t_f | | | 25 | | |
| SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ($T_c = 25^\circ\text{C}$) | | | | | | |
| Continuous Current | I_s | | | | 44 | A |
| Pulsed Current ³ | I_{SM} | | | | 100 | |
| Forward Voltage ¹ | V_{SD} | $I_F = I_s, V_{\text{GS}} = 0\text{V}$ | | | 1.3 | V |
| Reverse Recovery Time | t_{rr} | $I_F = 20\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$ | | 30 | | nS |
| Reverse Recovery Charge | Q_{rr} | | | | 130 | nC |

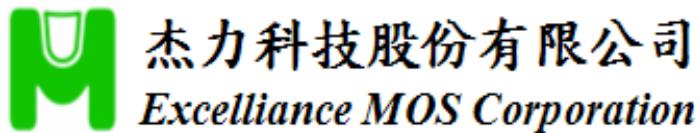


EMB14N10H

¹Pulse test : Pulse Width \leq 300 μ sec, Duty Cycle \leq 2%.

²Independent of operating temperature.

³Pulse width limited by maximum junction temperature.



EMB14N10H

Ordering & Marking Information:

Device Name: EMB14N10H for EDFN 5 x 6



→ B14N10: Device Name

→ ABCDEFG: Date Code

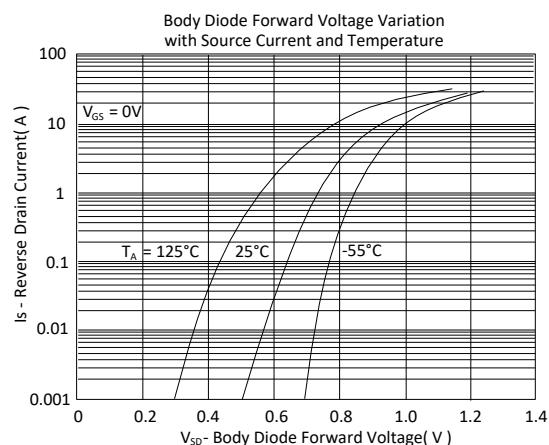
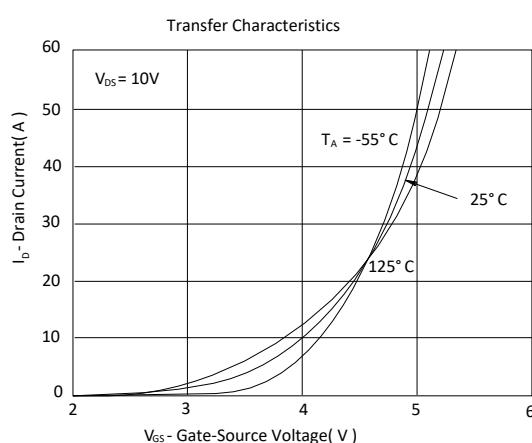
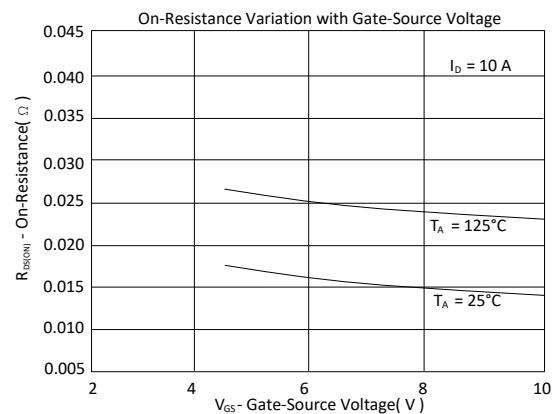
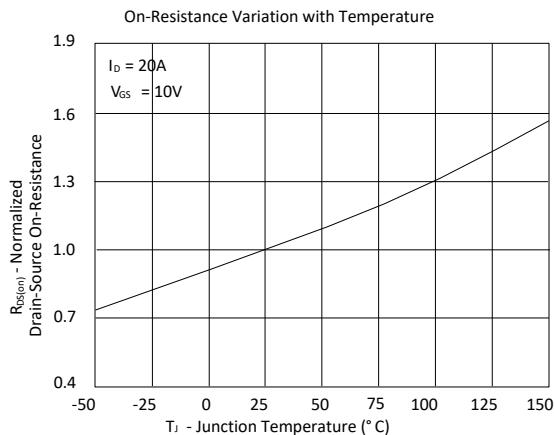
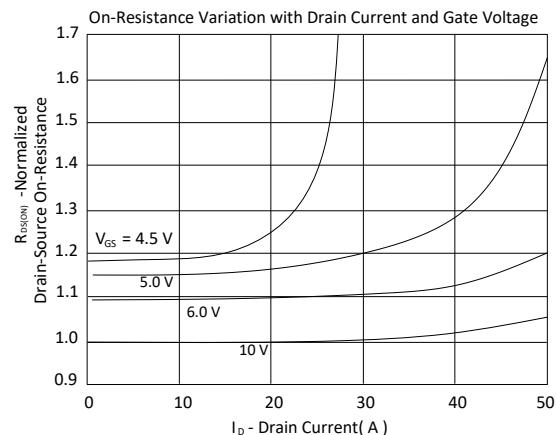
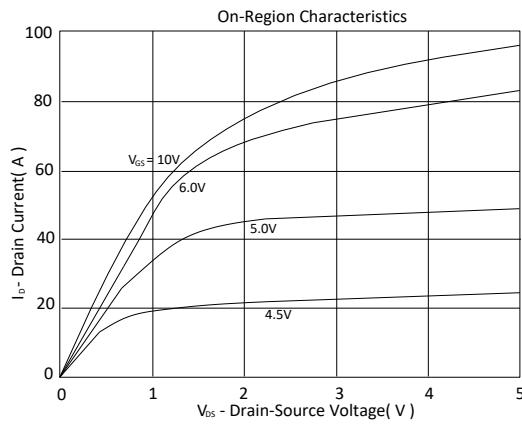
A: Assembly House

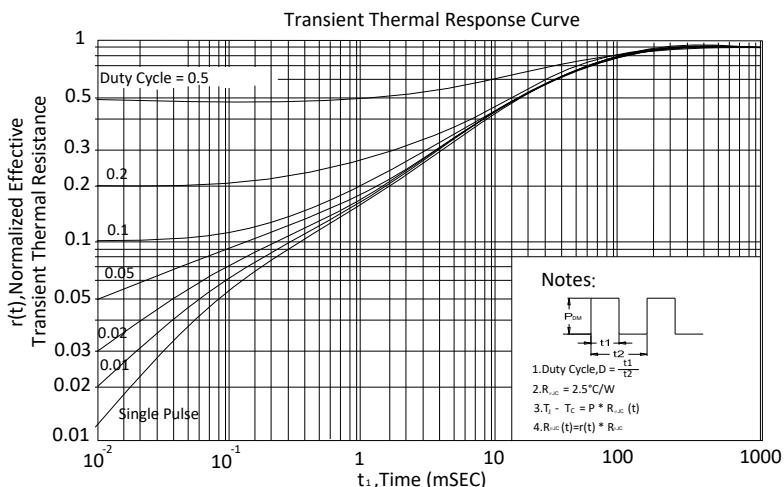
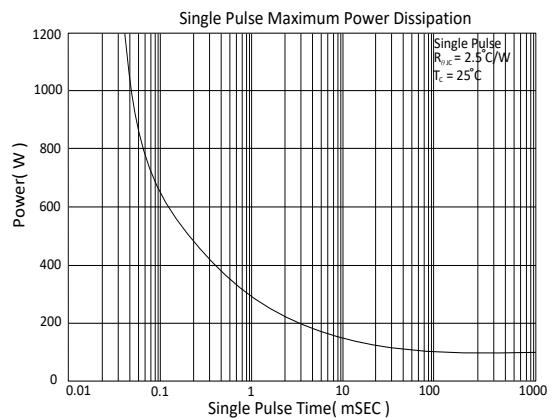
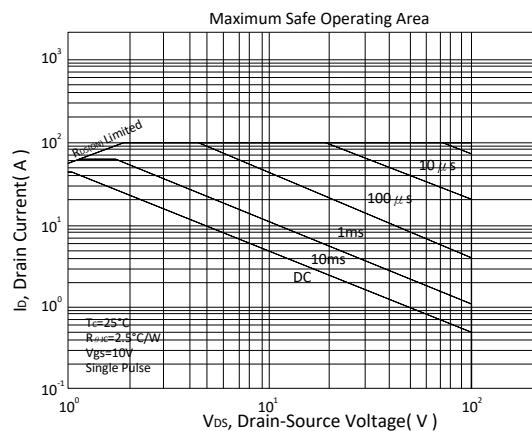
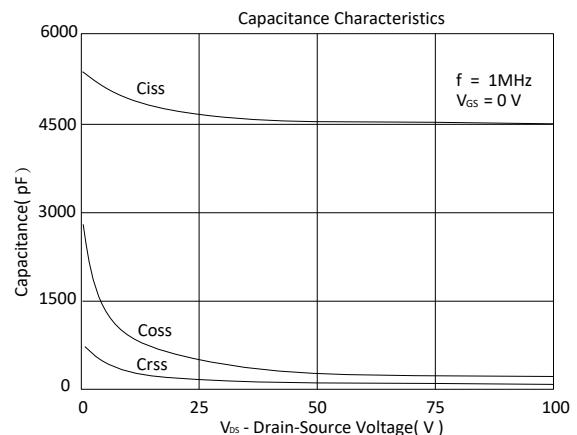
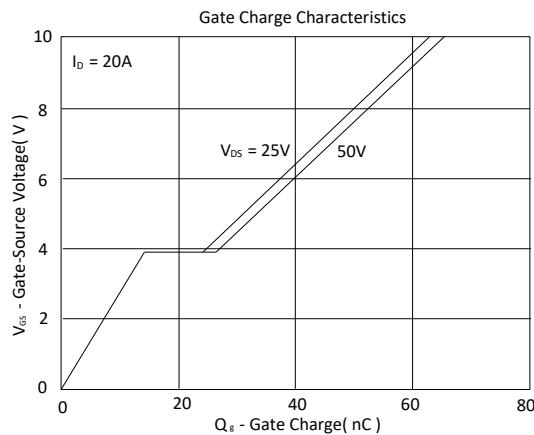
B: Year(A:2008 B:2009 C:2010....)

C: Month(A:01 B:02 C:03 D:04 E:05 F:06 G:07 H:08 I:09 J:10 K:11 L:12)

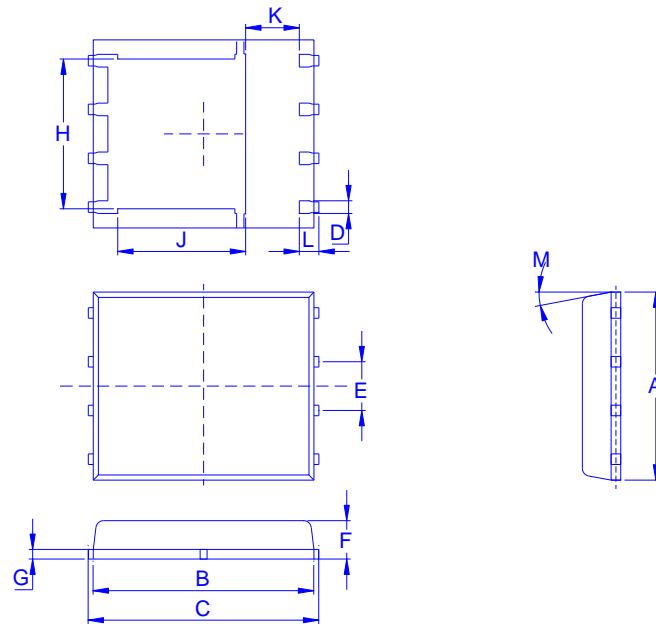
DEFG: Serial No.

TYPICAL CHARACTERISTICS





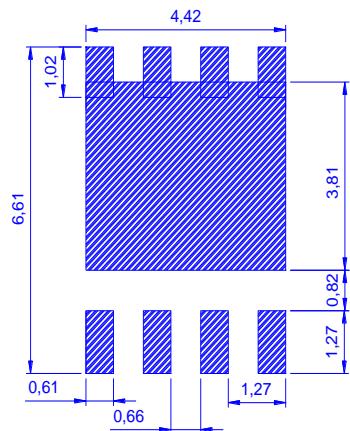
Outline Drawing



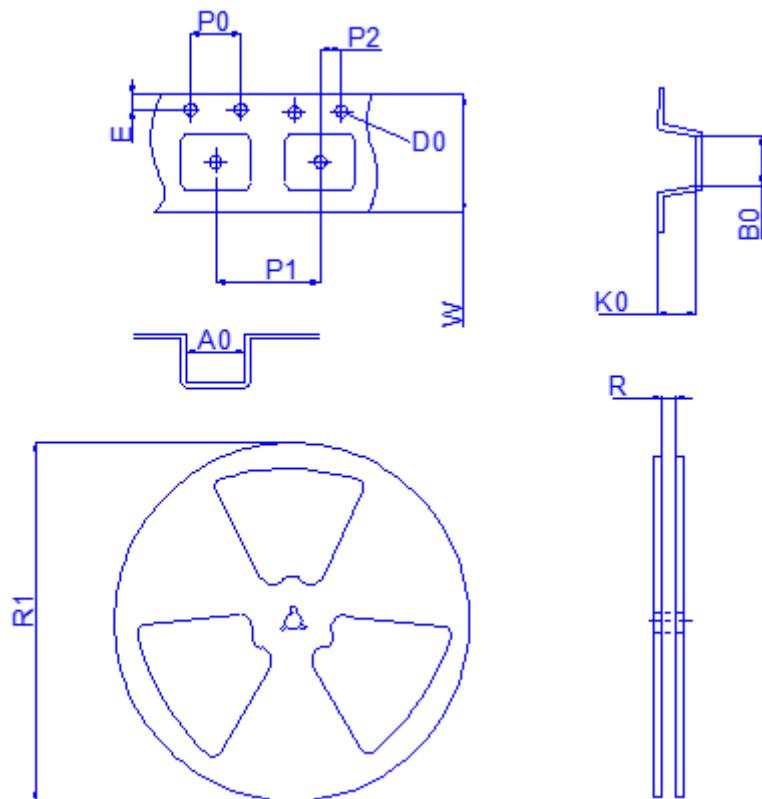
Dimension in mm

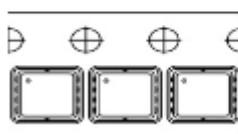
| Dimension | A | B | C | D | E | F | G | H | J | K | L | M |
|-----------|-----|------|------|------|------|------|------|------|------|------|------|-----|
| Min | 4.8 | 5.55 | 5.9 | 0.3 | 1.17 | 0.85 | 0.15 | 3.61 | 3.18 | 1 | 0.38 | 0° |
| Typ. | 4.9 | 5.7 | 6 | 0.4 | 1.27 | 0.95 | 0.2 | 3.87 | 3.44 | 1.2 | 0.4 | |
| Max | 5.4 | 5.85 | 6.15 | 0.51 | 1.37 | 1.17 | 0.34 | 4.31 | 3.78 | 1.39 | 0.71 | 12° |

Recommended minimum pads



Tape&Reel Information:2500pcs/Reel



| | |
|--------------------|--|
| Package | EDFN5X6 |
| Reel | 13" |
| Device orientation | FEED DIRECTION   |

Dimension in mm

| Dimension | Carrier tape | | | | | | | | Reel | | |
|-----------|--------------|-----|-----|-----|-----|-----|-----|-----|------|------|-----|
| | A0 | B0 | D0 | E | K0 | P0 | P1 | P2 | W | R | R1 |
| Typ. | 6.4 | 5.3 | 1.5 | 1.8 | 1.6 | 4 | 8 | 2 | 12 | 12.4 | 330 |
| ± | 0.2 | 0.2 | 0.1 | 0.1 | 0.6 | 0.1 | 0.1 | 0.1 | 0.3 | 2 | 2 |